Outline

Approximate system identification

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(Lecture 9) Approximate system identification

From exact to approximate identification

- From exact to approximate identification
- Misfit vs latency
- Misfit minimization
- Misfit computation
 - kernel
 - image
 - input/state/output

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Approximate system identification

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Exact system identification and the MPUM

Exact identification problem:

Given a vector time series

$$w_{\mathsf{d}} = \big(w_{\mathsf{d}}(1), \dots, w_{\mathsf{d}}(T)\big) \in (\mathbb{R}^{\mathsf{w}})^T$$

find the smallest $m \in \mathbb{N}$ and $\ell \in \mathbb{N}$ and LTI system $\mathscr{B}_{mpum} \in \mathscr{L}_{m\ell}^{W}$, s.t.

$$W_{\mathsf{d}} \in \mathscr{B}_{\mathrm{mpum}}$$
.

The model $\mathscr{B}_{\mathrm{mpum}} = \mathscr{B}_{\mathrm{mpum}}(w_{\mathrm{d}})$ is unique and is called the MPUM of w_{d} in the model class $\mathscr{L}_{\mathrm{m}\ell}^{\mathrm{w}}$.

There are effective algorithms for computing representations of $\mathscr{B}_{\mathrm{mpum}}(w_{\mathrm{d}})$ from given $w_{\mathrm{d}}=(u_{\mathrm{d}},y_{\mathrm{d}})$ and an upper bound ℓ_{max} on ℓ .

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Identifiability

Provided that $w_d \in \overline{\mathscr{B}} \in \mathscr{L}^w_{\mathfrak{m},\ell_{\mathsf{max}}}$, find conditions under which

$$\mathscr{B}_{\mathrm{mpum}}(w_{\mathsf{d}}) = \overline{\mathscr{B}}.$$

Main theoretical result in the exact identification setting:

 $\overline{\mathscr{B}}$ is identifiable from $w_d = (u_d, y_d)$ in $\mathscr{L}_{m,\ell_{max}}^w$ if

- 1. w_d is exact, *i.e.*, $w_d \in \overline{\mathscr{B}}$,
- 2. the model class is correct, i.e., $\overline{\mathscr{B}} \in \mathscr{L}_{\mathfrak{m},\ell_{\max}}^{\mathsf{w}}$,
- 3. u_d is persistently exciting of order $\ell_{max} + n$, and
- 4. $\overline{\mathscr{B}}$ is controllable

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MPUM in the case of "noisy" data

Q: What is the MPUM of a noisy trajectory

$$w_{\mathsf{d}} = \overline{w} + \widetilde{w}$$
 where $\overline{w} \in \overline{\mathscr{B}} \in \mathscr{L}^{\mathsf{w}}_{\mathsf{m},\ell_{\mathsf{max}}}$ (EIV) and \widetilde{w} is random and zero mean?

A: With probability 1,

$$\mathscr{B}_{ ext{mpum}}(\textit{W}_{\mathsf{d}}) = (\mathbb{R}^{\mathsf{w}})^{\mathbb{Z}_{+}}$$
 (all variables are inputs)

This is a trivial model because it fits every trajectory.

Alternatively, $\mathscr{B}_{mpum}(w_d)$ does not exist in a model class $\mathscr{M} = \mathscr{L}_{\mathfrak{m},\ell_{max}}^{\mathsf{w}}$ of bounded ($\mathfrak{m} < \mathfrak{w}$, $\ell_{max} \ll T$) complexity.

In what follows we assume a given bounded complexity model class $\mathcal{M} = \mathcal{L}_{\mathfrak{m},\ell_{\max}}^{\mathsf{w}}$, so we refer to lack of existence rather than trivial MPUM.

Notes

- · the conditions are only sufficient
- conditions 1, 2, and 4 are not verifiable from the given data and should therefore be postulated
- a known input/output partitioning of the data is assumed
- from a practical point of view, condition 1 is a strong assumption that limits the applicability of the exact SYSID methods

approaches for relaxing condition 1 are described next

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In practice, w_d is often generated by a

nonlinear, infinite dimensional, time-varying system $\overline{\mathscr{B}}$ possibly with process and measurement noises, *i.e.*, $\overline{\mathscr{B}} \notin \mathscr{L}^{\mathsf{w}}_{\mathsf{m},\ell_{\mathsf{max}}}$ \Longrightarrow even without noise, identifying exact model is often not possible

It can be argued that in practice the approximation aspect $(\widehat{\mathscr{B}} \approx \overline{\mathscr{B}})$ is often more important than the stochastic estimation $(\widehat{\mathscr{B}} \to \overline{\mathscr{B}})$ as $T \to \infty$

An approximate $\widehat{\mathscr{B}}\in\mathscr{L}^{\mathrm{w}}_{\mathrm{m},\ell_{\mathrm{max}}}$ is what is anyway needed:

Many prediction and control methods are based on LTI models

 \implies even if it was possible to identify $\overline{\mathscr{B}}$, it would be necessary to approximate it by $\widehat{\mathscr{B}}\in\mathscr{L}^{\mathsf{w}}_{\mathsf{m},\ell_{\mathsf{max}}}$

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Misfit vs latency

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Misfit approach for approximate SYSID

Consider given data w_d and model class $\mathscr{M} = \mathscr{L}^{\mathsf{w}}_{\mathsf{m},\ell_{\mathsf{max}}}$.

If the MPUM does not exists in M, i.e.,

$$\mathscr{B}_{\mathrm{mpum}}(w_{\mathsf{d}}) \notin \mathscr{M}$$

we aim to find an approximate model $\widehat{\mathscr{B}}$ for w_d in \mathscr{M} .

The misfit approach modifies w_d as little as possible, so that the modified data, say \widehat{w} , has MPUM in \mathcal{M} , i.e.,

$$\mathscr{B}_{\mathrm{mpum}}(\widehat{\mathbf{w}}) \in \mathscr{M}$$

The approximate model for w_d in \mathcal{M} is defined as $\widehat{\mathcal{B}}_{\text{misfit}} := \mathcal{B}_{\text{mpum}}(\widehat{\mathbf{w}})$.

The modification of the data is measured by the misfit $\|\mathbf{w}_d - \hat{\mathbf{w}}\|$

Modifications of the MPUM concept

Unless the model class $\mathscr{M}=\mathscr{L}^{\mathrm{w}}_{\mathrm{m},\ell_{\mathrm{max}}}$ is enlarged, i.e., $(\mathrm{m},\ell_{\mathrm{max}})$ is increased, until the MPUM exists in \mathscr{M}

we have to accept falsified models in ℳ

→ approximate SYSID

The main question in approximate SYSID is:

Q: Which (falsified) model in \mathcal{M} to choose?

A: In some sense the "least falsified" ("approximately unfalsified") one.

Two major notions of "least falsified" are small misfit and small latency.

They quantify the discrepancy between the model and the data.

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Latency

The latency approach augments w_d by, as small as possible, variable e, so that the augmented data $w_{\rm ext} := {\rm col}(e, w_{\rm d})$ has MPUM in the augmented model class, *i.e.*,

$$\mathscr{B}_{ ext{mpum}}ig(\operatorname{ ext{col}}(e, w_{ ext{d}})ig) \in \mathscr{M}_{ ext{ext}} := \mathscr{L}_{ ext{m}+e, \ell_{ ext{max}}}^{ ext{w}+e}$$

Let Π_w be the projection of $\mathrm{col}(e,w)$ on w. The approximate model for w_d in $\mathscr M$ is defined as

$$\widehat{\mathscr{B}}_{latency} := \Pi_{\mathsf{W}} \mathscr{B}_{mpum} (\operatorname{col}(e, \mathsf{W}_{\mathsf{d}}))$$

The size of e is measured by the latency ||e||

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Notes

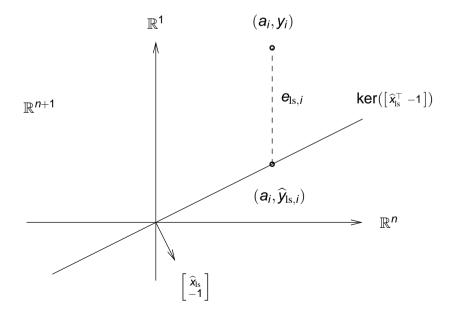
- Both the misfit and latency approaches reduce the approximate SYSID problem to (different) exact SYSID problems:
 - $\widehat{\mathscr{B}}_{\mathsf{misfit}}$ is exact for the modified data \widehat{w}
 - $\widehat{\mathscr{B}}_{latency}$ is obtained from an exact model for $col(e, w_d)$
- If $\mathscr{B}_{\mathrm{mpum}}(w_{\mathsf{d}}) \in \mathscr{M}$ (the data is exact),

$$\widehat{\mathscr{B}}_{\text{misfit}} = \widehat{\mathscr{B}}_{\text{latency}} = \mathscr{B}_{\text{mpum}}(w_{\text{d}})$$
 $(\widehat{w} = w_{\text{d}} \text{ and } e = 0)$

So, misfit and latency are indeed extensions of the MPUM.

- The misfit approach modifies w_d but does not change \mathcal{M} .
- The latency approach modifies \mathcal{M} but does not change w_d .

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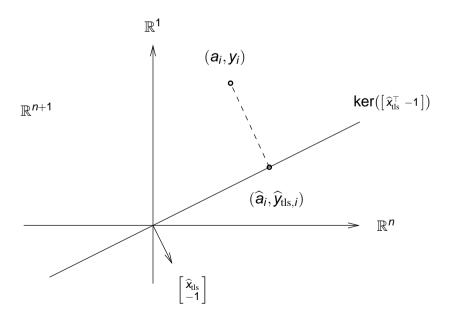


Static case: latency \leftrightarrow LS misfit \leftrightarrow TLS

LS: minimize_{e,x} $\|e\|_2$ subject to Ax = y + e e latent variable $|atency((A,y),x)| := \left(\min_{e} \|e\|_2^2 \text{ s.t. } Ax = y + e\right) = \|Ax - y\|_2^2$

$$\begin{split} \operatorname{misfit} \big((A,b), x \big) &:= \min_{\Delta A, \Delta b} \ \big\| \big[\Delta A \quad \Delta b \big] \big\|_{\operatorname{F}} \ \text{s.t.} \ (A + \Delta A) x = b + \Delta b \\ &= \frac{\|Ax - b\|_2}{\sqrt{1 + \|x\|_2^2}} \end{split}$$

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Statistical interpretation of misfit and latency

 $\begin{array}{ll} \text{misfit} & \leftrightarrow & \text{errors-in-variables (EIV) model} \\ \text{latency} & \leftrightarrow & \text{ARMAX model} \end{array}$

EIV model: $\widetilde{w} = (\widetilde{u}, \widetilde{y})$ — measurement errors



ARMAX model: e — process noise

$$\stackrel{e}{u_d} \longrightarrow \mathscr{B} \longrightarrow y_d$$

Assumptions: \widetilde{w} , e — zero mean, stationary, white, ergodic, Gaussian

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Misfit minimization

- $\Pi_{\mathsf{W}}\mathscr{B}_{\mathsf{ext}}$ deterministic part of the model
- $\Pi_e \mathscr{B}_{ext}$ stochastic part of the model

Notes:

- The Kalman filter and LQG control are based on the latency model
- ⇒ stochastic part is used by the KF and LQG controller

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Identification problems

Misfit minimization (GTLS): given $w_d \in (\mathbb{R}^w)^T$ and $\ell_{max} \in \mathbb{N}$, find

$$\widehat{\mathscr{B}}_{\mathsf{gtls}}^* := \arg\min_{\widehat{\mathscr{B}}, \widehat{w}} \quad \| w_\mathsf{d} - \widehat{w} \| \quad \mathsf{subject to} \quad \widehat{w} \in \widehat{\mathscr{B}} \in \mathscr{L}_{\mathsf{m},\ell_{\mathsf{max}}}$$

Latency minimization (PEM): given $w_d \in (\mathbb{R}^w)^T$ and $\ell_{max} \in \mathbb{N}$, find

$$\widehat{\mathscr{B}}_{\mathsf{pem}}^* := \arg\min_{\widehat{\mathscr{B}}_{\mathsf{ext}},\mathsf{e}} \quad \| \, \mathsf{e} \| \quad \mathsf{subject to} \quad (\, \mathsf{e},\widehat{\mathsf{w}}) \in \widehat{\mathscr{B}}_{\mathsf{ext}} \in \mathscr{L}_{\mathsf{m}+\mathsf{e},\ell_{\mathsf{max}}}$$

Notes:

- nonconvex optimization problems
- solution methods based on local optimization
- initial approximation obtained from subspace methods

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Misfit minimization

Define the misfit between w_d and \mathscr{B} as follows

$$\begin{split} & \mathsf{misfit}(w_\mathsf{d},\mathscr{B}) := \mathsf{minimize}_{\widehat{w}} \quad \|w_\mathsf{d} - \widehat{w}\|_{\ell_2} \quad \mathsf{subject to} \quad \widehat{w} \in \mathscr{B} \\ & \mathsf{the minimizer } \widehat{w}^* \; \mathsf{is projection of } \; w_\mathsf{d} \; \mathsf{on} \; \mathscr{B} \; (\mathsf{best} \; \ell_2 \; \mathsf{approx. of } \; w_\mathsf{d} \; \mathsf{in} \; \mathscr{B}) \\ & \mathsf{alternatively, } \; \widehat{w}^* \; \mathsf{is the smoothed estimate of } \; w_\mathsf{d}, \; \mathsf{given} \; \mathscr{B} \\ & \mathsf{our goal is to find the model} \; \widehat{\mathscr{B}} \; \mathsf{that minimizes misfit}(w_\mathsf{d},\mathscr{B}), \; \mathit{i.e.}, \end{split}$$

$$\widehat{\mathscr{B}} := \underset{\widehat{w}}{\operatorname{arg\,min}} \ \operatorname{misfit}(w_{\mathsf{d}},\mathscr{B}) \quad \operatorname{subject\ to} \quad \mathscr{B} \in \mathscr{M}$$

a double minimization problem: inner minimization is projection on a subspace (easy), outer minimization is a nonconvex problem (difficult)

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Misfit computation

Maximum likelihood estimator in the EIV setup

Assuming that the data is generated according to the model

$$w_d = \overline{w} + \widetilde{w}$$
, where $\overline{w} \in \overline{\mathscr{B}} \in \mathscr{M}$ and $\widetilde{w} \sim N(0, s^2 I)$

 $\widehat{\mathscr{B}}$ is the maximum likelihood estimator of the true model $\overline{\mathscr{B}}$

 $\widehat{\mathscr{B}}$ is a consistent estimator of the true model $\overline{\mathscr{B}}$, i.e., $\widehat{\mathscr{B}} \to \overline{\mathscr{B}}$ as $T \to \infty$

The log-likelihood function is ("const" does not depend on \widehat{w} and $\widehat{\mathscr{B}}$)

$$\ell(\widehat{\mathscr{B}},\widehat{w}) = \begin{cases} \mathsf{const} - \frac{1}{2s^2} \| w_\mathsf{d} - \widehat{w} \|_{\ell_2}^2, & \text{ if } \widehat{w} \in \widehat{\mathscr{B}} \in \mathscr{M} \\ -\infty, & \text{ otherwise,} \end{cases}$$

likelihood evaluation \iff misfit computation

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Computation of the misfit

Given w_d and $\mathscr{B} \in \mathscr{L}^{\mathsf{w}}_{\mathfrak{m},\ell_{\mathsf{max}}}$, find $\mathsf{misfit}(w_d,\mathscr{B}) := \mathsf{min}_{\widehat{w} \in \mathscr{B}} \|w_d - \widehat{w}\|_{\ell_2}$

 \mathscr{B} is subspace \implies the constraint is linear \implies ordinary LS problem

Using general purpose LS solvers, the comput. complexity is $O(T^3)$.

Time-invariance of \mathcal{B} , however, implies Toeplitz structure of the LS prob.

Structure exploiting misfit computation methods have complexity O(T).

They are based on:

- structured matrix computations
 (e.g., using displacement rank theory and the gen. Schur alg.)
- 2. Riccati recursions (Kalman smoother)

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Misfit computation using image representation

$$\mathsf{minimize}_{\widehat{w}} \quad \| w_\mathsf{d} - \widehat{w} \|_{\ell_2} \quad \mathsf{subject to} \quad \widehat{w} \in \mathscr{B} := \mathsf{image} \left(M(\sigma) \right) \quad \mathsf{(M)}$$

Recall from Lecture 5 that

$$w \in \mathcal{B} \iff w = \underbrace{\begin{bmatrix} M_0 & M_1 & \cdots & M_\ell & & \\ & M_0 & M_1 & \cdots & M_\ell & & \\ & & \ddots & \ddots & & \ddots & \\ & & & M_0 & M_1 & \cdots & M_\ell \end{bmatrix}}_{\mathcal{T}_M} \begin{bmatrix} v(1) \\ v(2) \\ \vdots \\ v(T+\ell) \end{bmatrix}$$

So that (M) is an ordinary least squares problem

$$minimize_{v} \quad \|w_{d} - \mathcal{T}_{M}v\| \tag{M'}$$

and

$$\mathsf{misfit}\big(w_\mathsf{d},\mathsf{image}\big(M(\sigma)\big)\big) = w_\mathsf{d}^\top \mathscr{T}_M\big(\mathscr{T}_M^\top \mathscr{T}_M\big)^{-1} \mathscr{T}_M^\top w_\mathsf{d}$$

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In order to solve (R') explicitly, we need a basis for null (\mathscr{T}_R) . Let

N be such that $\mathscr{T}_R N = 0$ and N is full column rank

Then, $\mathscr{T}_R \widehat{w} = 0 \iff \exists z \in \mathbb{R}^{\operatorname{coldim}(N)} \text{ s.t. } \widehat{w} = Nz, \text{ and }$

$$\mathsf{misfit}\big(w_\mathsf{d}, \mathsf{ker}\big(R(\sigma)\big)\big) = w_\mathsf{d}^\top N \big(N^\top N\big)^{-1} N^\top w_\mathsf{d}.$$

Note that the columns of \mathcal{T}_M form a particular basis for the null space of \mathcal{T}_R . This can be seen algebraically from

$$\mathcal{T}_R \mathcal{T}_M = 0$$
 and \mathcal{T}_M is full column rank

or (better) from a system theoretic point of view:

$$\operatorname{col}\operatorname{span}\left(\mathscr{T}_{R}\right)=\operatorname{null}\left(\mathscr{T}_{R}\right)=\mathscr{B}_{T}.$$

Misfit computation using kernel representation

 $\mathsf{minimize}_{\widehat{w}} \quad \| \textit{w}_{\mathsf{d}} - \widehat{w} \|_{\ell_2} \quad \mathsf{subject to} \quad \widehat{w} \in \mathscr{B} := \ker \big(\textit{R}(\sigma) \big) \qquad \text{(R)}$

Recall from Lecture 5 that

$$w_{\mathsf{d}} \in \mathscr{B} \iff \underbrace{\begin{bmatrix} R_0 & R_1 & \cdots & R_\ell & & \\ & R_0 & R_1 & \cdots & R_\ell & & \\ & & \ddots & \ddots & & \ddots & \\ & & & R_0 & R_1 & \cdots & R_\ell \end{bmatrix}}_{\mathscr{T}_T(R)} \begin{bmatrix} w_{\mathsf{d}}(1) \\ w_{\mathsf{d}}(2) \\ \vdots \\ w_{\mathsf{d}}(T) \end{bmatrix} = 0$$

So that (R) is an equality constrained least squares problem

minimize_{$$\widehat{w}$$} $\|w_d - \widehat{w}\|_{\ell_2}$ subject to $\mathscr{T}_R \widehat{w} = 0$ (R')

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Efficient reduction of (R) to (M)

Computing N, reduces (R) to (M), however, N need not be Toeplitz.

Moreover, computing N by general purpose methods is expensive, while the path $R \mapsto M \mapsto \mathscr{T}_M$ is cheap.

Let $R(z) =: \begin{bmatrix} Q(z) & P(z) \end{bmatrix}$ with $P(z) \in \mathbb{R}^{p \times p}[z]$ nonsingular (this is equivalent to assuming existence of I/O partition $w = \operatorname{col}(u, y)$)

Compute the right matrix fraction of $G(z) := P^{-1}(z)Q(z)$

$$G(z) = Q_1(z)P_1^{-1}(z)$$

Then

$$M(z) = \begin{bmatrix} P_{\mathsf{I}}(z) \\ Q_{\mathsf{I}}(z) \end{bmatrix}$$

which also reduces (R) to (M).

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Misfit computation using I/S/O representation

minimize_{$$\widehat{w}$$} $\|w_d - \widehat{w}\|_{\ell_2}$ subject to $\widehat{w} \in \mathscr{B} := \mathscr{B}_{i/s/o}(A, B, C, D)$ (SS)

Recall from Lecture 5 that

$$w = (u, y) \in \mathscr{B}_{i/s/o}(A, B, C, D) \iff \text{there exists } x_{ini} \in \mathbb{R}^n, \text{ such that }$$

$$y = \underbrace{\begin{bmatrix} C \\ CA \\ CA^2 \\ \vdots \\ CA^{T-1} \end{bmatrix}}_{\mathscr{O}} \mathbf{x}_{\text{ini}} + \underbrace{\begin{bmatrix} H(0) \\ H(1) & H(0) \\ H(2) & H(1) & H(0) \\ \vdots & \ddots & \ddots & \ddots \\ H(T-1) & \cdots & H(2) & H(1) & H(0) \end{bmatrix}}_{\mathscr{T}_H} u$$

where H(0) = D and $H(t) = CA^{t-1}B$, for t = 1, 2, ...

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References

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Then (SS) is equivalent to the ordinary LS problem:

$$\mathsf{minimize}_{\mathsf{x}_{\mathsf{ini}},\widehat{u}} \quad \left\| \begin{bmatrix} \mathsf{u}_{\mathsf{d}} \\ \mathsf{y}_{\mathsf{d}} \end{bmatrix} - \begin{bmatrix} \mathsf{I} & \mathsf{0} \\ \mathscr{O} & \mathscr{T}_{\mathsf{H}} \end{bmatrix} \begin{bmatrix} \mathsf{x}_{\mathsf{ini}} \\ \widehat{u} \end{bmatrix} \right\| \tag{SS'}$$

Efficient solution via Riccati recursion --> Kalman smoother

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Software

A Matlab toolbox:

Exercises 3 applies a simple GTLS algorithm on benchmark problem and compares the results with the ones of the latency minimization approach, implemented in the System Identification Toolbox.

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